

# STE140NF20D

### N-channel 200 V, 0.010 Ω, 140 A, ISOTOP STripFET™ II with fast recovery diode Power MOSFET

Preliminary Data

### Features

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STE140NF20D	200 V	< 0.012 Ω	140 A

- Exceptional dv/dt capability
- Low gate charge
- 100% avalanche tested

### Application

Switching applications

### Description

This Power MOSFET is produced using STMicroelectronics' unique STripFET<sup>™</sup> process, which is specifically designed to minimize input capacitance and gate charge. The STE140NF20D offers extremely fast switching performance thanks to the instrinsic fast body diode, making the device ideal for hard switching topologies.

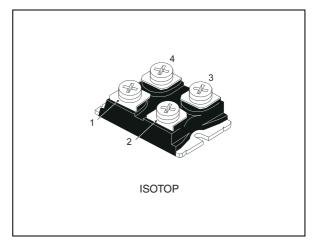
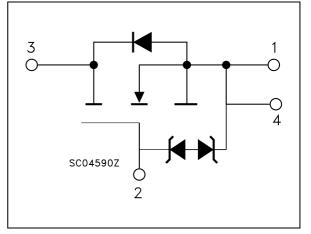


Figure 1. Internal schematic diagram



#### Table 1.Device summary

Order code	Marking	Package	Packaging
STE140NF20D	140NF20D	ISOTOP	Tube

This is preliminary information on a new product now in development or undergoing evaluation. Details are subject to change without notice.

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## **Electrical ratings**

Table 2.	Absolute maximum	ratings
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Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> = 0)	200	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	140	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> =100 °C	260	А
$I_{DM}^{(2)}$	Drain current (pulsed)	560	А
P <sub>TOT</sub> <sup>(2)</sup>	Total dissipation at $T_C = 25 \ ^{\circ}C$	500	W
	Derating factor	4	W/°C
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	25	V/ns
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	- 55 to 150	°C

1. The value is rated according  $R_{thj\text{-}pcb}$ 

2. Pulse width limited by safe operating area

3. I\_{SD}  $\leq$  30 A, di/dt  $\leq$  TBD A/µs, V<sub>DD</sub>  $\leq$  80% V<sub>(BR)DSS</sub>

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	0.25	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient	40	°C/W

#### Table 4. Avalanche data

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not repetitive <sup>(1)</sup>	TBD	А
E <sub>AS</sub>	Single pulse avalanche energy <sup>(2)</sup>	TBD	mJ

1. Pulse width limited by Tjmax

2. Strating Tj = 25 °C,  $I_D$  =  $I_{AR},\,V_{DD}$  = 50 V

# 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 1$ mA, $V_{GS} = 0$	200			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = max rating, V <sub>DS</sub> =max rating @125 °C			10 100	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 21 V$			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 70 A		0.010	0.012	Ω

### Table 5.On/off states

#### Table 6. Dynamic

	<b>D</b> y manne					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub>	Forward transconductance	$I_{D} = 140 \text{ A}, V_{DS} = 150 \text{ V}$		TBD		
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 25 V, f=1 MHz, V <sub>GS</sub> =0		9900 2000 450		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> =480 V, I <sub>D</sub> = 140A V <sub>GS</sub> = 4.5 V <i>(see Figure 3)</i>		390 TBD TBD		nC nC nC



	•					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 100 \text{ V}, I_D = 70 \text{ A}, R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 2)		TBD TBD TBD TBD		ns ns ns ns

 Table 7.
 Switching times

#### Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				140	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				560	А
$V_{SD}^{(2)}$	Forward on voltage	I <sub>SD</sub> = 70 A, V <sub>GS</sub> =0			1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 70 A,		TBD		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/µs,		TBD		nC
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> = 100 V, Tj=150 °C		TBD		А

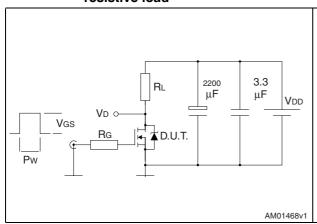
1. Pulse width limited by safe operating area

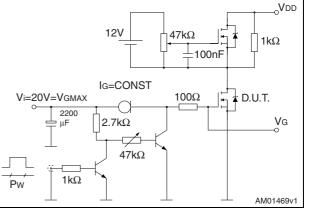
2. Pulsed: pulse duration=300µs, duty cycle 1.5%



#### **Test circuit** 3

Figure 2. Switching times test circuit for resistive load

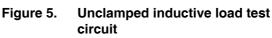


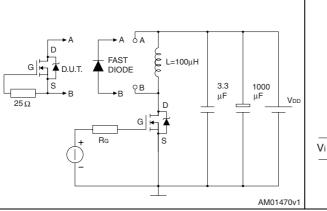


Gate charge test circuit

Figure 3.

Figure 4. Test circuit for inductive load switching and diode recovery times





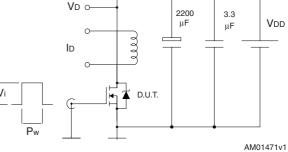




Figure 7. Switching time waveform

ton V(BR)DSS toff tdoff tf tdon VD 90% 90% ldм 10% 10% VDS lр 0 Vdd Vdd 90% Vgs 10% AM01472v1 0\_ AM01473v1

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Vdd

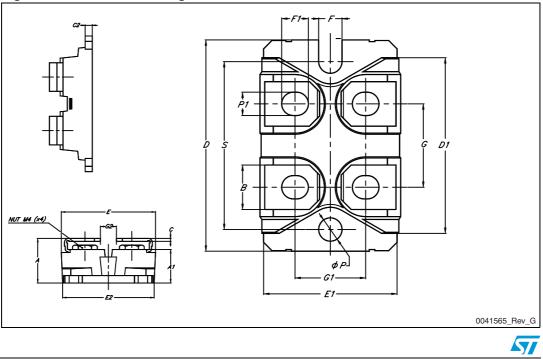
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.



Dim.	mm			
	Min.	Тур.	Max.	
А	11.80		12.20	
A1	8.90		9.10	
В	7.80		8.20	
С	0.75		0.85	
C2	1.95		2.05	
D	37.80		38.20	
D1	31.50		31.70	
E	25.15		25.50	
E1	23.85		24.15	
E2		24.80		
G	14.90		15.10	
G1	12.60		12.80	
G2	3.50		4.30	
F	4.10		4.30	
F1	4.60		5	
φP	4		4.30	
P1	4		4.40	
S	30.10		30.30	

### Figure 8. ISOTOP drawing



## 5 Revision history

### Table 10. Document revision history

Date	Revision	Changes
27-Jan-2009	1	First release



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